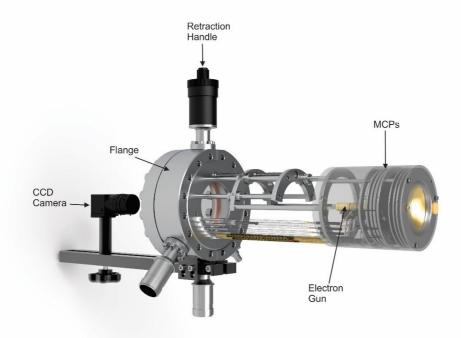


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# LEED 600 MCP Configuration Guide and Specifications



#### **LEED** configuration

Base confi	<u> </u>		
Model	Order Code		
BDL600IR- MCP1-3GR		Back-Display LEED optics, with 3 Grid-high resolution (0.2%) retarding field analyzer based on gold plated tungsten hemispherical grids with 75 deg. capture angle, integral miniature electron gun, lenses made of gold plated copper alloy, optical quality flat glass display, one 80 mm Long Life(TM) microchannel plate(MCP) and Mu-metal shield mounted on the double sided CF 6" (DN100CF) flange with vacuum insert diameter 94 mm. Viewport and mountin kit included. Wide beam current range: from pA to uA. Working Distance: 15 mm. Flange to sample distance: to be specified.	
LMX		Integral linear retraction based on 4 linear ball bearings up to 100 mm	
LPS075-D		Digital power supply (0-750 V) with USB interface and PC control software for Windows 10. True primary beam current and total emission measurements. Automatic start-up and shut down, 10 memory settings including standby and outgassing mode with timer, constant beam current mode controlled by filament current or Wehnelt voltage. All cables included.	
MCPS1		Electronics for one microchannel plate with digital displays of voltages and MCP load current measurements and protection.	
Options			
LaB <sub>6</sub>		LaB <sub>6</sub> single crystal filament instead of a tungsten wire filament	
MCP2		Two 80 mm LongLife™ microchannel plates (MCP) in chevron configuration instead of one MCP	
MCPS2		Electronics for two microchannel plates with digital displays of voltages and MCP load current measurements and protection.	
Electronics	s Upgrade		
LPS300-D-		Upgrade from LPS075-D to LPS300-D	



UP	
LOA10-AES	Model LOA10-AES, Digital AES controller with lock-in amplifier, AES high voltage ramp board 0-2.0 kV with precision sinewave oscillator (0.5-20 Vpk-pk) and AES software. Serial RS232 or USB communication to PC. High Auger signal sensitivity based on integrated band-pass filter and pre-amplifier (0.05% of monolayer for Ag peak 351-356 eV). All cables included.

### **LEED and AES configuration**

Base config	uration	
Model	Order Code	
BDL600IR- MCP1-4GR		Back-Display LEED optics, with 4 Grid-high resolution (0.2%) retarding field analyzer based on gold plated tungsten hemispherical grids with 75 deg. capture angle, integral miniature electron gun, lenses made of gold plated copper alloy, optical quality flat glass display, one 80 mm Long Life(TM) microchannel plate(MCP) and Mu-metal shield mounted on the double sided CF 6" (DN100CF) flange with vacuum insert diameter 94 mm. Viewport and mounting kit included. Wide beam current range: from pA to uA. Working Distance: 15 mm. Flange to sample distance: to be specified.
LMX		Integral linear retraction based on 4 linear ball bearings up to 100 mm
LPS300-D		Digital LEED-Auger power supply (0-3.2 kV) with USB interface and PC control software for Windows 7. True primary beam current and total emission measurements. Automatic start-up and shut down, 10 memory settings including outgassing with timer, automatic switch from LEED to AES, constant beam current mode. All cables included.
MCPS1		Electronics for one microchannel plate with digital displays of voltages and MCP load current measurements and protection.
Options		
LaB <sub>6</sub>		LaB <sub>6</sub> single crystal filament instead of a tungsten wire filament
LOA10-AES		Model LOA10-AES, Digital AES controller with lock-in amplifier, AES high voltage ramp board 0-2.0 kV with precision sinewave oscillator (0.5-20 Vpk-pk) and AES software. Serial RS232 or USB communication to PC. High Auger signal sensitivity based on integrated band-pass filter and pre-amplifier (0.05% of monolayer for Ag peak 351-356 eV). All cables included.
MCP2		Two 80 mm LongLife™ microchannel plates (MCP) in chevron configuration instead of one MCP
MCPS2		Electronics for two microchannel plates with digital displays of voltages and MCP load current measurements and protection.

#### **LEED Software**

Software (	Options	
Model	Order Code	
LIM12		Full version LEED pattern measurements, analysis software & hardware for Windows 10 including: -12-bit colour or black and white high-performance video CCD camera with sensitivity control - 1/3" CCD sensor size, 1.3 MP (1288x964) - sized images, 3.75 um pixel size, CS-mount lenses - Linear Full Well: 9000e-, Dynamic Range: 59 dB
		<ul> <li>- Elliear Full Well: 9000e-, Dynamic Range: 39 db</li> <li>- PCle express USB3.1 card (option if computer doesn't have USB3.1)</li> <li>- Flange mounting kit with ambient light cover and cables</li> <li>Software features:</li> <li>- Automatic LEED pattern acquisition</li> <li>- Automatic I-V analysis with spot tracking</li> </ul>



	- Automatic I-T analysis
	- Automatic spot profile analysis
LIM12B	Basic LEED pattern measurements and analysis software and hardware for
	Windows 10 including:
	-12-bit colour high performance video CCD camera with sensitivity control and
	USB3 interface
	-1/3" CCD sensor size, image size: 1.3 MP (1288x964), 3.75 um pixel size, CS-mount lenses
	-Linear Full Well: 9000e-, Dynamic Range: 59 dB
	-PCle express USB3.1 card (option if computer doesn't have USB3.1)
	-Automatic LEED pattern acquisition
	-Flange Mounting kit with ambient light cover and cables
LIM14	Advanced LEED pattern measurements, analysis software & hardware for
	Windows 10 including:
	-14-bit colour or black and white high-performance scientific grade CCD camera
	with sensitivity control and USB 3 interface: 2/3" CCD sensor size and 1.4-
	megapixel resolution (1384x1032), 6.45 um pixel size, C-mount lenses
	- Linear Full Well: 22,000e-, extremely low noise, Dynamic Range: 68 dB
	- PCle express USB3.1card (option if computer doesn't have USB3.1)
	- Flange mounting kit with ambient light cover and cables.
	Software features:
	- Automatic LEED pattern acquisition
	- Automatic I-V analysis with spot tracking
	- Automatic I-T analysis
	- Automatic spot profile analysis

## **Detailed Specifications**

BDL600IR-MCP optics		
Glass display	Fused silica glass coated with indium-tin oxide conductive layer and P31 phosphor (ZnS:Ag:Cu-green, 525 nm wavelength)	
Angle of acceptance	92° from sample at a distance of 51 mm	
Retarding Field Analyzer	Concentric assembly of hemispherical grids	
Working distance from	15 mm	
sample		
Grid material	Gold coated tungsten wire mesh (100 mesh, 81% transparency)	
Energy resolution	0.2% -0.5% at low modulation voltage	
Monitoring	6" standard viewport	
Linear motion	Up to 100 mm retraction from sample; linear ball bearing and acme thread with all spring electrical connections	
Magnetic shielding	Mu metal cylinder with front cover for maximum attenuation	
Assembly	Extreme high vacuum compatibility with stainless steel, high alumina and Au-plated copper alloy materials	
Mounting	CF6" (DN100CF) double sided conflat flange with sample distance 145 mm - 400 mm	
Bakeability	Under vacuum, 250°C maximum	

Integral miniature electron gun		
Beam energy	LEED: 0-750 eV	
	AES: 0-3000 eV	
Beam current	LEED: 2 μA at 100 eV and 0.5 mm beam size	
	AES: up to 100 μA at 3 keV	
Beam size	From 1 mm to 250 µm-adjusted by wehnelt potential, limited by	
	exchangeable aperture down to 50 μm	
Electron source	Tungsten 2% thoriated filament (standard) or single crystal LaB filament	
	(optional)	
Energy spread	0.45 eV (thoriated-tungsten filament)	
Overall size	10 mm lens diameter and 80 mm length	



Microchannel Plates		
Working area	75 mm	
L/D ratio	40:1	
Channel diameter	25 microns	
Center to center spacing	32 microns	
Plate thickness	1.0 mm	
Bias angle	8°	
Electron gain	10⁴ to 10⁵ per plate	

LPS075-D and LPS300-D Electronics		
Beam Voltage	LPS075-D: negative 0-750 V	
	LPS300-D: negative 0-3000 V	
Filament current	0-3.2 A Tungsten/ 0-2.1 A LaB₀	
Wehnelt voltage	0-37 V with respect to the filament	
Focus voltage	LEED: positive 70-180% of the beam voltage	
	AES: negative 0-3000 V	
Retarding (grid) voltage	Negative 50-110% of the beam voltage	
Screen voltage	Positive 0-5000 V	
Emission current	1-200 μA	
Beam current	0.01-200 μA	
Monitoring	All voltages and currents	
Display	Vacuum fluorescent, displaying all voltages, currents and program functions	
On-board automation	5 pre-programmed and fully programmable operating programs for	
	outgassing, stand-by, filament forming, beam voltage scanning, constant	
	beam current and diagnostics	
Manual control	Of all voltages via rotary dials and selection switches	
PC control	PC software for full control of all functions via USB	
Protection	Over-voltage, over-current, and short circuit	
Dimensions	3U 19" rack mount (5.25"/133 mm), depth of 17.5" (440 mm), weight 12 kg	

High Voltage Ram	p Generator Model LOA10	-AES (Lock-In)
Sweep Generator	Sweep Voltage	0-2000 V
	Sweep Rate	AES software controlled (16-bit DAC)
	Sweep Voltage Offset (start)	AES software controlled (16-bit DAC)
	Sweep Voltage Offset (end)	AES software controlled (16-bit DAC)
	Ramp Voltage Monitor	AES software controlled (16-bit DAC)
Internal Oscillator	Frequency	Fixed at 1.457 kHz, trimmer adjusted ±5%
and Modulator	Amplitude (peak-to-peak)	Regulated from 0.5 to 20 V (16-bit DAC)
	Distortion	Harmonic 0.1%
		Noise 50 μV RMS
PSD	Туре	Switching multiplier
	Input Impedance	AC coupled, 100 nF into 1 MΩ
	Input	True differential
	AC Gain	10, 100, 1000, 10000 (and 1, 2, 4, 8) software
		selectable
	Interstage Coupling	Simple high pass typically with 3 dB per 72 Hz
	Post Detection Low Pass	Equal component Sallen-Key, 2nd order with a time
	Filter	constant of 0.1, 0.5, 1, and 3 s
	Signal Channel Equivalent	Typically, less than 20 nV/Hz at 1 kHz
	Input Noise	
PLL	Input Impedance	AC coupled, $10 \text{ nF}$ into $1 \text{ M}\Omega$
	Frequency Range	0.2-7.5 kHz with a typical phase jitter < 0.2%
	Locks Onto	The fundamental or 2nd harmonic
ADC	Chip	TI ADS7807
	Resolution	16 bits
	Accuracy	±1.5 LSB max INL
	Conversion Time	25 μs
DAC	Chip	TI DAC715
	Resolution	16 bits



	Settling Time	3 μs
	Channels	1
Computer Interface	USB	
Software	AES data acquisition and analysis software for Windows 7/10	
Dimensions	2U 19" rack mount (3.5" / 89 mm), depth of 13.5" (343 mm), weight 6 kg.	

Low Noise Input Coupler Model AUS30				
Input Impedance	10 MΩ (internal bandpass filte	10 M $\Omega$ (internal bandpass filter)		
Amplifier	FET input, 500 gain	FET input, 500 gain		
Dimensions	180 mm × 105 mm × 65 mm			
Low Noise Bandpass	Central Frequency 2.95 kHz			
Filter	3 dB Band Width 200 Hz			
	20 dB Band Width	7.83 kHz		